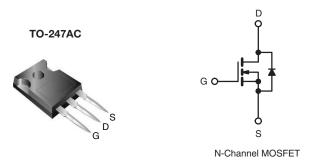


Vishay Siliconix

### Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	600				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.60				
Q <sub>g</sub> (Max.) (nC)	84				
Q <sub>gs</sub> (nC)	18				
Q <sub>gd</sub> (nC)	36				
Configuration	Single				



#### **FEATURES**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Isolated Central Mounting Hole
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

TO-247AC The package preferred commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFPC50LCPbF		
Lead (i b)-liee	SiHFPC50LC-E3		
SnPb	IRFPC50LC		
Sill b	SiHFPC50LC		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		$V_{DS}$	600	V	
Gate-Source Voltage		$V_{GS}$	± 30	1	
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	I_	11		
Continuous Brain Current	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	7.3	Α	
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	44		
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	920	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	11	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	19	mJ		
Maximum Power Dissipation	kimum Power Dissipation T <sub>C</sub> = 25 °C		190	W	
Peak Diode Recovery dV/dtc	dV/dt	3.0	V/ns		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 13 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 11 A (see fig. 12). c.  $I_{SD} \le$  11 A,  $dI/dt \le$  100 A/ $\mu$ s,  $V_{DD} \le$   $V_{DS}$ ,  $T_J \le$  150 °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFPC50LC, SiHFPC50LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	SYMBOL TYP. MAX.		UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I <sub>D</sub> = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 20 V	-	-	± 100	nA
Zana Oata Valtana Duain Ourmant		V <sub>DS</sub> = 60	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 480 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6.6 A <sup>b</sup>	-	-	0.60	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 10	00 V, I <sub>D</sub> = 6.6 A <sup>b</sup>	7.0	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V	<sub>GS</sub> = 0 V,	-	2300	-	
Output Capacitance	C <sub>oss</sub>	V	os = 25 V,	-	270	-	рF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 l	MHz, see fig. 5	-	28	-	
Total Gate Charge	Qg		V <sub>GS</sub> = 10 V		-	84	
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V			-	18	nC
Gate-Drain Charge	Q <sub>gd</sub>		l see light called to	-	-	36	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 300 V, $I_{D}$ = 11 A , $R_{g}$ = 6.2 $\Omega$ , $R_{D}$ = 30 $\Omega$ , see fig. 10 <sup>b</sup>		-	17	-	
Rise Time	t <sub>r</sub>			-	32	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	41	-	
Fall Time	t <sub>f</sub>			-	26	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") fro	Between lead, 6 mm (0.25") from		5.0	-	
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	13	-	nH
Drain-Source Body Diode Characteristic	s				·		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	11	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			I	-	44	A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C I	11 A dl/dt = 100 A/uch	ı	590	890	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 11  \text{A}, dI/dt = 100  \text{A}/\mu\text{s}^b$		-	4.5	6.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> ar			y L <sub>S</sub> and	L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

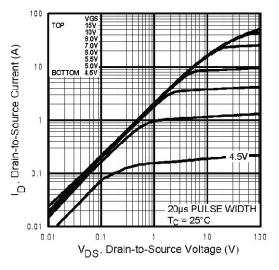


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

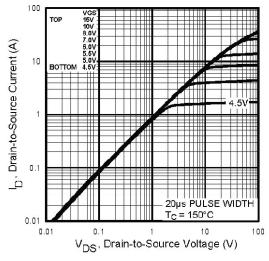


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

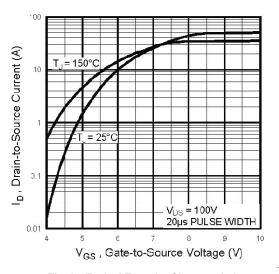


Fig. 3 - Typical Transfer Characteristics

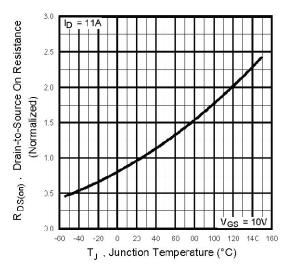


Fig. 4 - Normalized On-Resistance vs. Temperature

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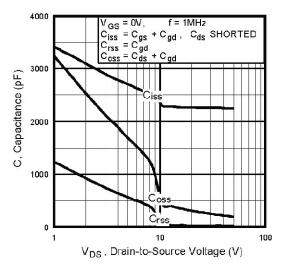


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

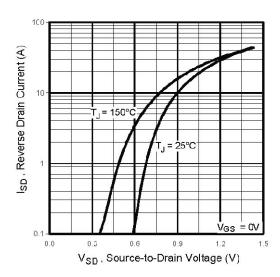


Fig. 7 - Typical Source-Drain Diode Forward Voltage

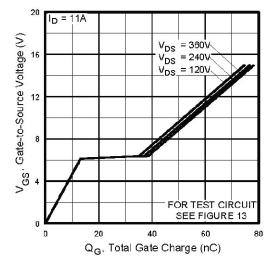


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

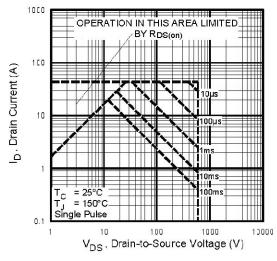


Fig. 8 - Maximum Safe Operating Area



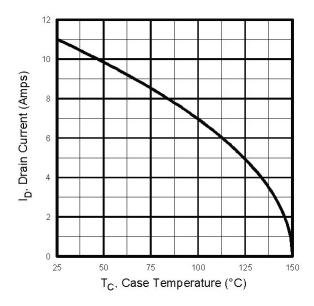


Fig. 9 - Maximum Drain Current vs. Case Temperature

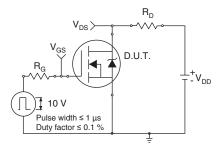


Fig. 10a - Switching Time Test Circuit

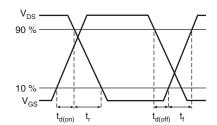


Fig. 10b - Switching Time Waveforms

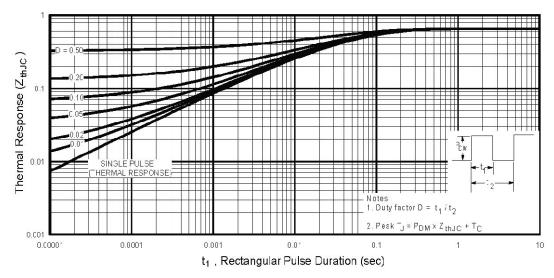
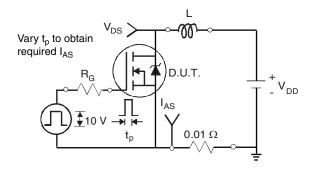


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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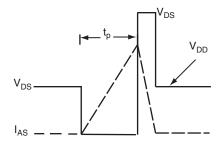


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

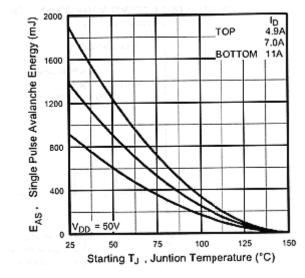


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

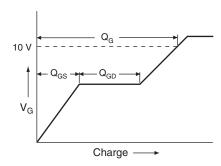


Fig. 13a - Basic Gate Charge Waveform

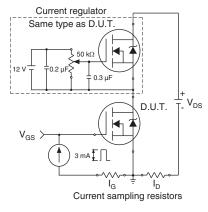
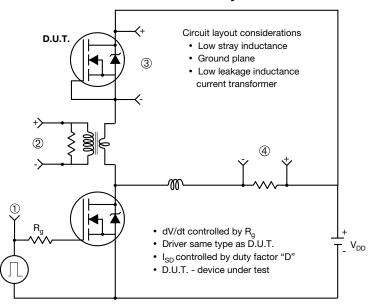


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



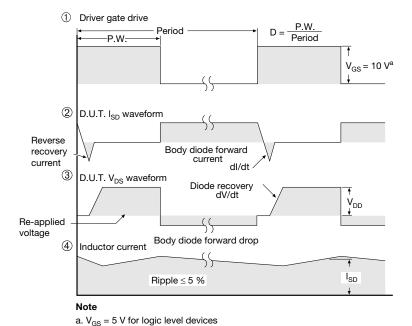
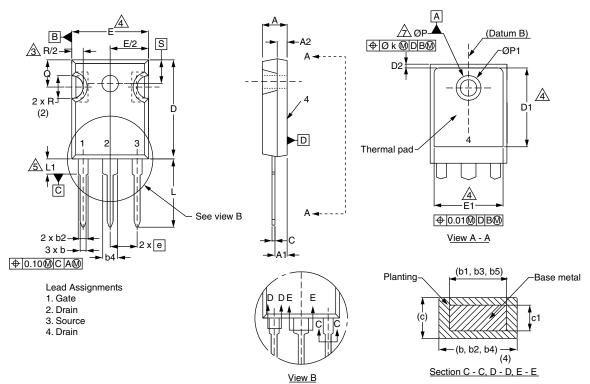


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91242.



# **TO-247AC (High Voltage)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	1

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D2	0.51	1.30	0.020	0.051
E	15.29	15.87	0.602	0.625
E1	13.72	ı	0.540	ı
е	5.46	BSC	0.215	BSC
Øk	0.2	254	0.0	10
L	14.20	16.25	0.559	0.640
L1	3.71	4.29	0.146	0.169
N	7.62 BSC		0.300 BSC	
ØΡ	3.51	3.66	0.138	0.144
Ø P1	-	7.39	-	0.291
Q	5.31	5.69	0.209	0.224
R	4.52	5.49	0.178	0.216
S	5.51 BSC		0.217	BSC

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 01-Jul-13 Document Number: 91360



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